

10/575378

PATENT APPLICATION  
IAP15 Rec'd PCT/PTO 11 APR 2006

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Junichi TANAKA et al.

Application No.: New U.S. National Stage of  
PCT/JP2004/017078

Filed: April 11, 2006

Docket No.: 127648

For: METHOD AND DEVICE FOR EXAMINATION OF NONUNIFORMITY DEFECTS OF PATTERNS

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

Pursuant to 37 CFR §1.56, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached PTO-1449. Unless otherwise indicated herein, one copy of each reference is attached. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

- 1. This Information Disclosure Statement is being filed (a) within three months of the U.S. filing date of this non-CPA application, OR (b) before the mailing date of a first Office Action on the merits in the present application. No certification or fee is required.
- 2. Relevance of one or more non-English language reference is discussed in the present specification. See Reference 2.
- 3. One or more reference cited herein was cited in the International Search Report. An English language version of the International Search Report is attached for the Examiner's information. See Reference 1.
- 4. An English language Abstract of one or more non-English language reference is attached hereto. See References 1-2.
- 5. A computer-generated English language translation of one or more Japanese Patent Publication cited herein has been obtained from the website of the Japanese Patent Office ([<http://www.jpo.go.jp>]), and is attached, but has not been reviewed for accuracy. See References 1-2.

Respectfully submitted,

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JAO:WPB/jrb

Date: April 11, 2006

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Form PTO-1449 (REV. 1/06)			US Dept. of Commerce PATENT & TRADEMARK OFFICE  INFORMATION DISCLOSURE STATEMENT  (Use several sheets if necessary)		ATTY DOCKET NO. 127648		APPLICATION NO. New U.S. National Stage of PCT/JP2004/017078	
					APPLICANTS Junichi TANAKA et al.			
					FILING DATE April 11, 2006			
<b>U.S. PATENT DOCUMENTS</b>								
Examiner Initials	Cite No.	Document Number	Date	Name				
<b>FOREIGN PATENT DOCUMENTS</b>								
Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation		
	1	JP A 2003-297888	10/17/2003	Japan	X	X		
	2	JP A 10-300447	11/13/1998	Japan	X	X		
<b>OTHER DOCUMENTS</b>								
Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)						
<b>EXAMINER</b>						<b>DATE CONSIDERED</b>		
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								

Date: April 11, 2006